

100V N-Channel Enhancement Mode MOSFET

Description

The AP5N10MI-L uses advanced Trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

$V_{DS} = 100V$ $I_D = 5A$

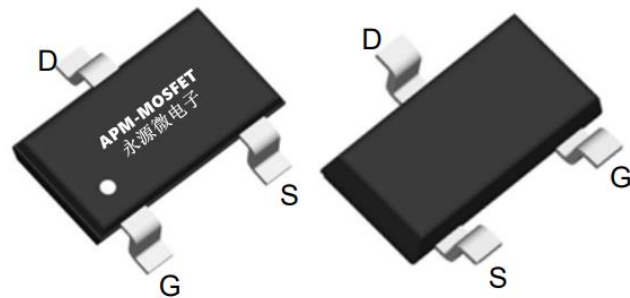
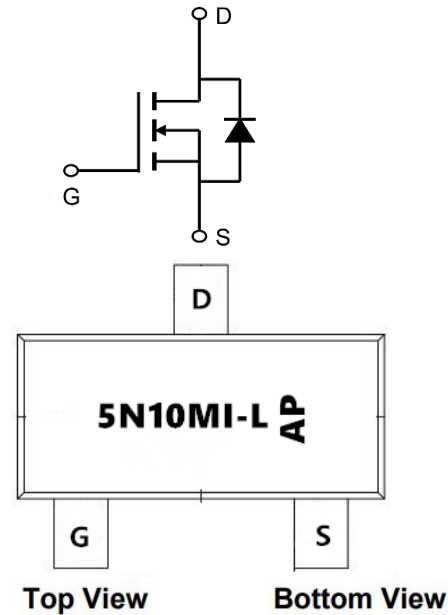
$R_{DS(ON)} < 140m\Omega$ @ $V_{GS}=10V$ (Type: 115m Ω)

Application

Automotive lighting

Load switch

Uninterruptible power supply



Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
AP5N10MI-L	SOT23-3L	5N10M-LAP	3000

Absolute Maximum Ratings ($T_C=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	100	V
V_{GS}	Gate-Source Voltage	± 20	V
$I_D@T_A=25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V^1$	5	A
$I_D@T_A=70^\circ C$	Continuous Drain Current, $V_{GS} @ 10V^1$	3.0	A
IDM	Pulsed Drain Current ²	18	A
$P_D@T_A=25^\circ C$	Total Power Dissipation ³	3.1	W
TSTG	Storage Temperature Range	-55 to 150	$^\circ C$
T_J	Operating Junction Temperature Range	-55 to 150	$^\circ C$
$R_{\theta JA}$	Thermal Resistance Junction-ambient(steady state) ¹	135	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance Junction-ambient($t < 10s$) ¹	40	$^\circ C/W$

100V N-Channel Enhancement Mode MOSFET

Electrical Characteristics (T_J=25°C, unless otherwise noted)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
V(BR)DSS	Drain-Source Breakdown Voltage	V _{GS} = 0V, I _D = 250μA	100	110	-	V
IGSS	Gate-body Leakage Current	V _{DS} = 0V, V _{GS} = ±20V	-	-	±100	nA
IDSS	Zero Gate Voltage Drain Current	V _{DS} = 100V, V _{GS} = 0V	-	-	1	μA
VGS(th)	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250μA	1.2	1.7	2.5	V
RDS(on)	Drain-Source On-state Resistance ³	V _{GS} = 10V, I _D = 3A	-	115	140	mΩ
		V _{GS} = 4.5V, I _D = 1A	-	125	180	
Ciss	Input Capacitance	V _{GS} = 0V, V _{DS} = 50V, f = 1MHz	-	200	-	pF
Coss	Output Capacitance		-	35	-	
Crss	Reverse Transfer Capacitance		-	2.5	-	
Q _g	Total Gate Charge	V _{DS} = 50V, V _{GS} = 10V, I _D = 3A	-	4	-	nC
Q _{gs}	Gate-Source Charge		-	0.9	-	
Q _{gd}	Gate-Drain Charge		-	1.1	-	
td(on)	Turn-on Delay Time	V _{DD} = 50V, V _{GS} = 10V, I _D = 3A, R _G = 3Ω	-	3.6	-	ns
t _r	Turn-on Rise Time		-	1.6	-	
td(off)	Turn-off Delay Time		-	8.5	-	
t _f	Turn-off Fall Time		-	2.6	-	
VSD	Body Diode Voltage ³	I _S = 3A, V _{GS} = 0V	-	-	1.2	V
IS	Continuous Source Current	-	-	-	3.3	A

Note :

- 1、The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.
- 2、The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%
- 3、The power dissipation is limited by 150°C junction temperature
- 4、The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

100V N-Channel Enhancement Mode MOSFET

Typical Characteristics

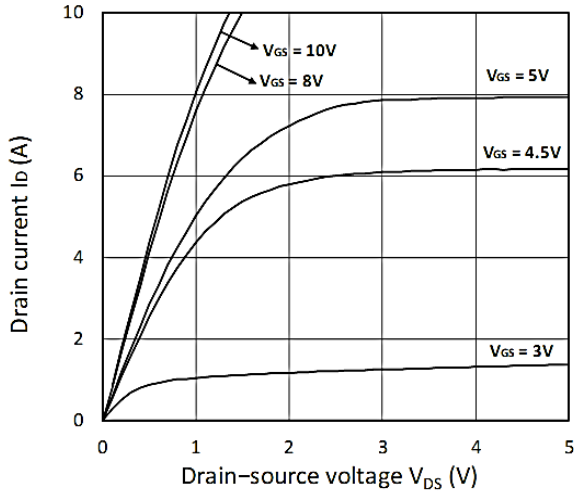


Figure 1. Output Characteristics

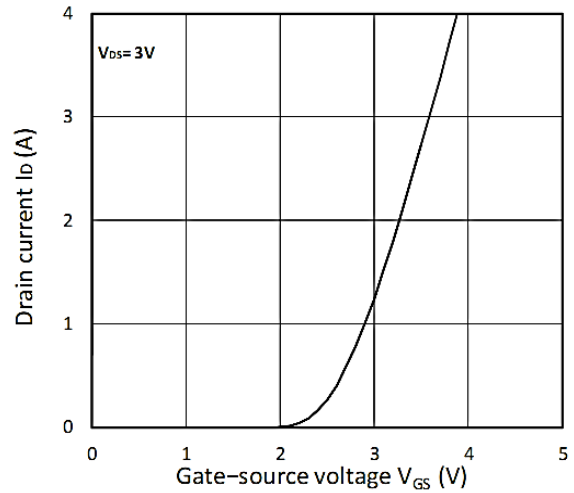


Figure 2. Transfer Characteristics

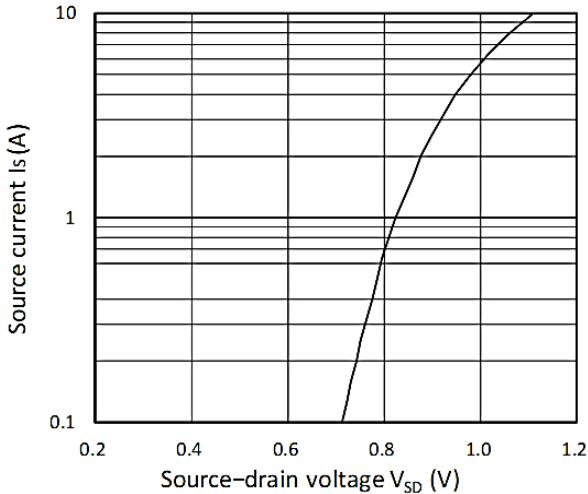


Figure 3. Forward Characteristics of Reverse

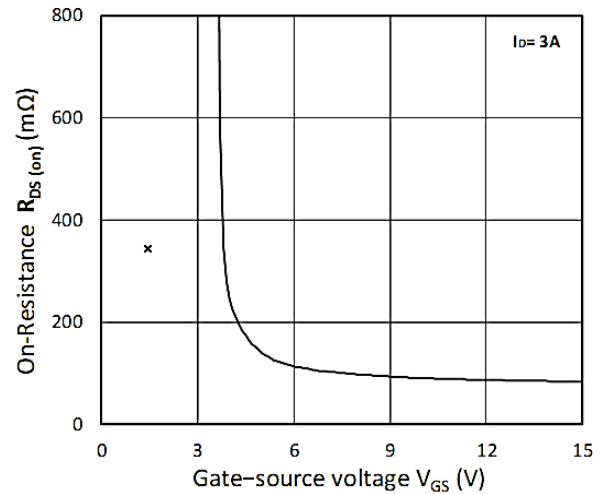


Figure 4. RDS(ON) vs. VGS

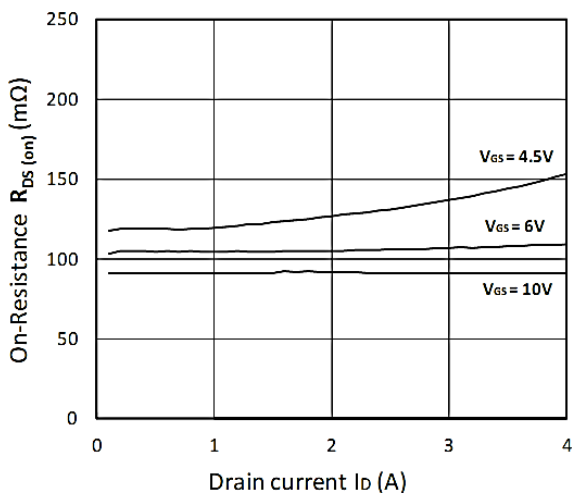


Figure 5. RDS(ON) vs. ID

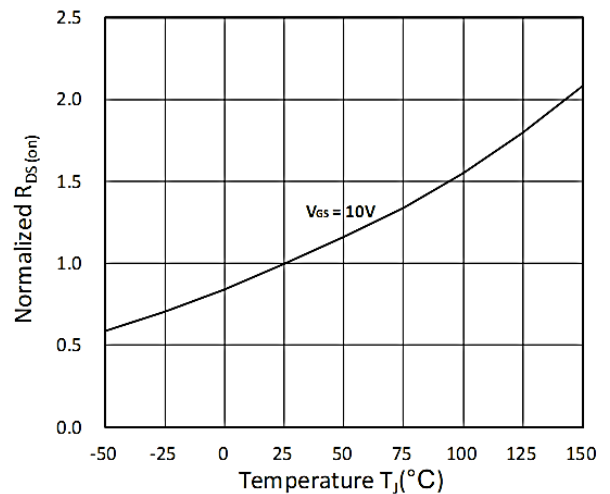


Figure 6. Normalized RDS(on) vs. Temperature

100V N-Channel Enhancement Mode MOSFET

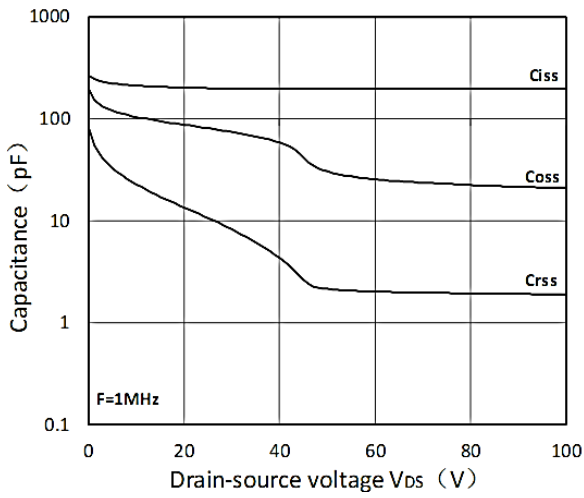


Figure7. Capacitance Characteristics

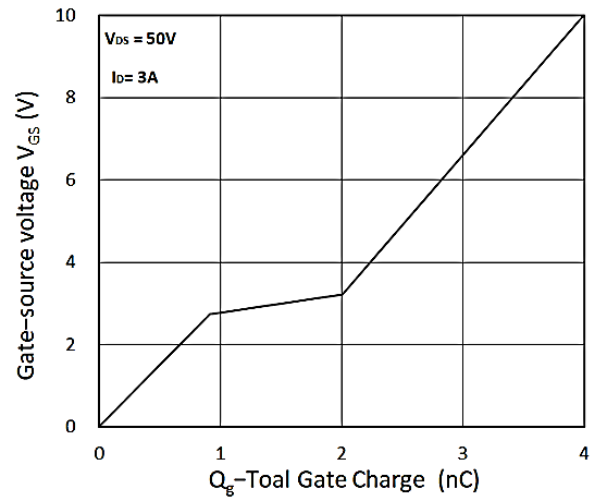
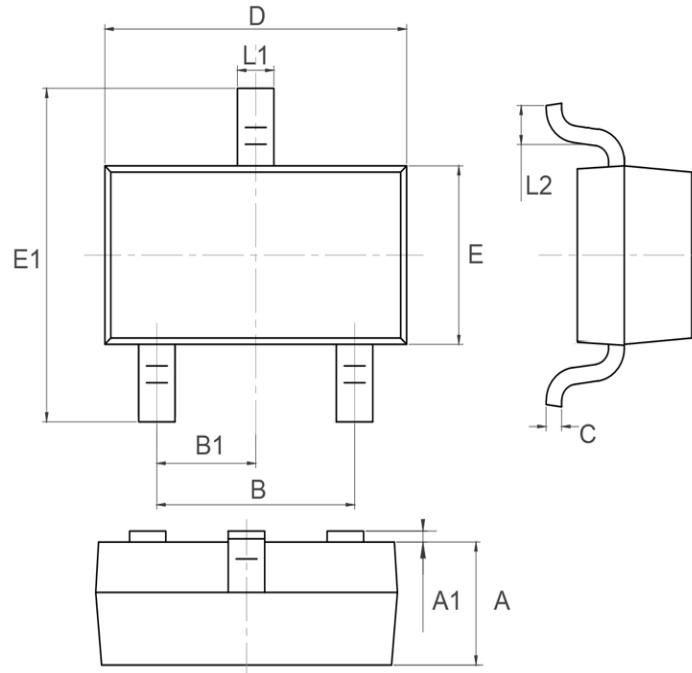


Figure8. Gate Charge Characteristics

100V N-Channel Enhancement Mode MOSFET

Package Mechanical Data-SOT23-3L-Single



Symbol	Dim in mm		
	Min	Typ	Max
A	1	1.1	1.2
A1	0	0.05	0.1
B	1.8	1.9	2
B1	0.95TYP		
C	0.1	0.15	0.2
D	2.82	2.92	3.02
E	1.5	1.6	1.7
E1	2.65	2.8	2.95
L1	0.3	0.4	0.5
L2	0.3	0.45	0.6

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Edition	Date	Change
REV1.0	2023/8/9	Initial release

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